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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: **Yusuke HASHIMOTO, et al.**

Serial Number: **Not Yet Assigned**  
(§371 of International Application PCT/JP05/05469)

Filed: **January 6, 2006**

For: **LIGHT DETECTING ELEMENT AND CONTROL METHOD OF LIGHT DETECTING ELEMENT**

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

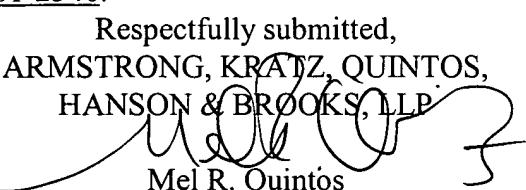
January 6, 2006

Sir:

In compliance with 37 CFR 1.56, Applicants call to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449 and cited in the enclosed international search report. References AA-AC, AE-AF and AJ are cited in the international search report.

A copy of each of the references, except for the U.S. patents and U.S. patent publication, is enclosed herewith.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. 01-2340.

Respectfully submitted,  
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**23850**

PATENT TRADEMARK OFFICE

Enclosures: PTO-1449; References (4); International Search Report

<b>INFORMATION DISCLOSURE STATEMENT PTO-1449</b>	Atty. Docket No. <b>050851</b>	Serial No. <b>10/156361</b>
	Applicant(s): <b>Yusuke HASHIMOTO, et al.</b>	
	<b>Filing Date: January 6, 2006</b>	<b>Group Art Unit: Not Yet Assigned</b>

**U.S. PATENT DOCUMENTS**

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
AA	6,150,676	M. Sasaki	11/21/00			
AB	3,435,236	J.A. Love, III, et al.	03/25/69			
AC	2004/0021057	C.I. Drowley	02/05/04			
AD						

**FOREIGN PATENT DOCUMENTS**

	Document No.	Date	Country	Translation (Yes or No)
AE	1 028 470 A2	08/16/00	EP	
AF	197 04 496 A1	03/12/98	Germany	Yes-Abstract
AG	2001-337166	12/07/01	Japan	Yes and Abstract/Discussed in the specification
AH				
AI				

**OTHER DOCUMENTS**

	AJ	P. Gulden, et al.; "Novel Optical Distance Sensor Based on MSM Technology;" <i>Proceedings of IEEE Sensors 2002. Orlando, Florida, June 12-14, 2002, IEEE International Conference on Sensors, New York, New York: IEEE, US, Vol. 1 of 2, Conf. 1; June 12, 2002; pp. 86-91.</i>
	AK	
Examiner		Date Considered